

Notice of References Cited	Application/Control No. 09/687,606		Applicant(s)/Patent Under Reexamination KLEIN, ENRIQUE J.	
	Examiner Alvin J Stewart		Art Unit 3738	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0058989 A1	05-2002	Chen et al.	623/1.15
*	B	US-2004/0102836 A1	05-2004	Fischell et al.	623/001.15
*	C	US-6,093,157 A	07-2000	Chandrasekaran, Verivada C.	600/585
*	D	US-2002/0010505	01-2002	Richter, Jacob	623/1.15
*	E	US-6,464,723 B1	10-2002	Callol, Joseph R.	623/1.34
*	F	US-6,468,302 B2	10-2002	Cox et al.	623/1.15
*	G	US-6,273,910 B1	08-2001	Limon, Timothy A.	623/1.15
*	H	US-5,741,327	04-1998	Frantzen, John J.	623/1.34
*	I	US-6,071,296 A	06-2000	Lashinski et al.	606/194
*	J	US-6,312,456 B1	11-2001	Kranz et al.	623/1.13
*	K	US-5,913,896 A	06-1999	Boyle et al.	623/1.15
*	L	US-			
*	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	WO01/00112A1	01-2001	WO	Padilla	623/1.34
*	O	EP0800801A1	10-1997	EP	Limon	623/1.34
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.